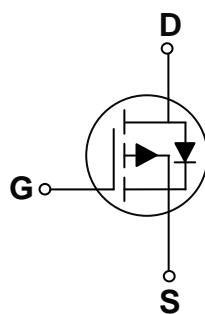
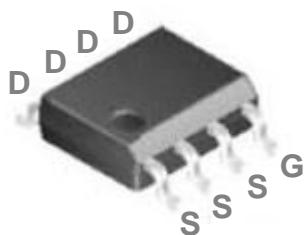


30V P-Channel MOSFETs

General Description

These P-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

SOP-8 Pin Configuration



| BVDSS | RDS(ON) | ID |
|-------|---------|------|
| -30V | 15.5mΩ | -10A |

Features

- -30V, -10A, RDS(ON) = 15.5mΩ @ VGS = -10V
- Fast switching
- Green Device Available
- Suit for -4.5V Gate Drive Applications

Applications

- MB / VGA / Vcore
- POL Applications
- Load Switch
- LED Application

Absolute Maximum Ratings (T_C=25 °C unless otherwise noted)

| Symbol | Parameter | Rating | Units |
|------------------|---|------------|-------|
| V _{DS} | Drain-Source Voltage | -30 | V |
| V _{GS} | Gate-Source Voltage | ±20 | V |
| I _D | Drain Current – Continuous (T _C =25 °C) | -10 | A |
| | Drain Current – Continuous (T _C =100 °C) | -6.3 | A |
| I _{DM} | Drain Current – Pulsed ¹ | -40 | A |
| P _D | Power Dissipation (T _C =25 °C) | 2.5 | W |
| | Power Dissipation – Derate above 25 °C | 0.02 | W/°C |
| T _{STG} | Storage Temperature Range | -55 to 150 | °C |
| T _J | Operating Junction Temperature Range | -55 to 150 | °C |

Thermal Characteristics

| Symbol | Parameter | Typ. | Max. | Unit |
|------------------|--|------|------|------|
| R _{θJA} | Thermal Resistance Junction to ambient | --- | 50 | °C/W |



FTK3905

30V P-Channel MOSFETs

Electrical Characteristics ($T_J=25^\circ\text{C}$, unless otherwise noted)

Off Characteristics

| Symbol | Parameter | Conditions | Min. | Typ. | Max. | Unit |
|------------------------------|------------------------------------|---|------|-------|-----------|---------------------------|
| BV_{DSS} | Drain-Source Breakdown Voltage | $V_{GS}=0\text{V}$, $I_D=-250\mu\text{A}$ | -30 | --- | --- | V |
| $\Delta BV_{DSS}/\Delta T_J$ | BV_{DSS} Temperature Coefficient | Reference to 25°C , $I_D=-1\text{mA}$ | --- | -0.03 | --- | $\text{V}/^\circ\text{C}$ |
| I_{DSS} | Drain-Source Leakage Current | $V_{DS}=-30\text{V}$, $V_{GS}=0\text{V}$, $T_J=25^\circ\text{C}$ | --- | --- | -1 | μA |
| | | $V_{DS}=-24\text{V}$, $V_{GS}=0\text{V}$, $T_J=125^\circ\text{C}$ | --- | --- | -10 | μA |
| I_{GSS} | Gate-Source Leakage Current | $V_{GS}=\pm 20\text{V}$, $V_{DS}=0\text{V}$ | --- | --- | ± 100 | nA |

On Characteristics

| | | | | | | |
|---------------------|-----------------------------------|--|------|------|------|----------------------------|
| $R_{DS(\text{ON})}$ | Static Drain-Source On-Resistance | $V_{GS}=-10\text{V}$, $I_D=-8\text{A}$ | --- | 12.4 | 15.5 | $\text{m}\Omega$ |
| | | $V_{GS}=-4.5\text{V}$, $I_D=-6\text{A}$ | --- | 19.2 | 25 | $\text{m}\Omega$ |
| $V_{GS(\text{th})}$ | Gate Threshold Voltage | $V_{GS}=V_{DS}$, $I_D=-250\mu\text{A}$ | -1.0 | -1.6 | -2.5 | V |
| | | | --- | 4 | --- | $\text{mV}/^\circ\text{C}$ |
| g_{fs} | Forward Transconductance | $V_{DS}=-10\text{V}$, $I_D=-8\text{A}$ | --- | 10.5 | --- | S |

Dynamic and switching Characteristics

| | | | | | | |
|--------------|------------------------------------|---|-----|------|------|----|
| Q_g | Total Gate Charge ^{2,3} | $V_{DS}=-15\text{V}$, $V_{GS}=-4.5\text{V}$, $I_D=-8\text{A}$ | --- | 14.6 | 21 | nC |
| Q_{gs} | Gate-Source Charge ^{2,3} | | --- | 4.1 | 6 | |
| Q_{gd} | Gate-Drain Charge ^{2,3} | | --- | 6.3 | 9 | |
| $T_{d(on)}$ | Turn-On Delay Time ^{2,3} | $V_{DD}=-15\text{V}$, $V_{GS}=-10\text{V}$, $R_G=6\Omega$ $I_D=-1\text{A}$ | --- | 9 | 17 | ns |
| T_r | Rise Time ^{2,3} | | --- | 21.8 | 41 | |
| $T_{d(off)}$ | Turn-Off Delay Time ^{2,3} | | --- | 59.8 | 114 | |
| T_f | Fall Time ^{2,3} | | --- | 14.4 | 27 | |
| C_{iss} | Input Capacitance | | --- | 1730 | 2510 | pF |
| C_{oss} | Output Capacitance | $V_{DS}=-15\text{V}$, $V_{GS}=0\text{V}$, $F=1\text{MHz}$ | --- | 180 | 260 | |
| C_{rss} | Reverse Transfer Capacitance | | --- | 125 | 180 | |

Drain-Source Diode Characteristics and Maximum Ratings

| Symbol | Parameter | Conditions | Min. | Typ. | Max. | Unit |
|----------|---------------------------|--|------|------|------|------|
| I_s | Continuous Source Current | $V_G=V_D=0\text{V}$, Force Current | --- | --- | -10 | A |
| | | | --- | --- | -40 | A |
| V_{SD} | Diode Forward Voltage | $V_{GS}=0\text{V}$, $I_s=-1\text{A}$, $T_J=25^\circ\text{C}$ | --- | --- | -1 | V |

Note :

- Repetitive Rating : Pulsed width limited by maximum junction temperature.
- The data tested by pulsed , pulse width $\leq 300\text{us}$, duty cycle $\leq 2\%$.
- Essentially independent of operating temperature.

30V P-ChannelMOSFETs

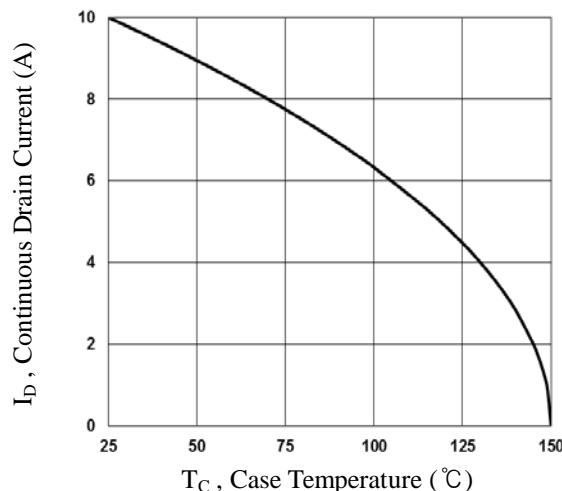


Fig.1 Continuous Drain Current vs. T_C

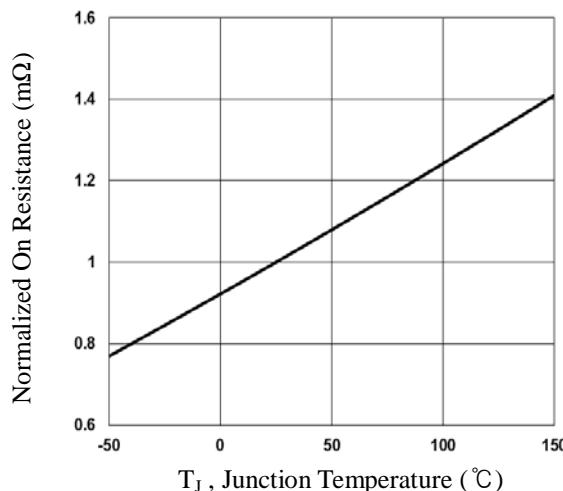


Fig.2 Normalized RDS(on) vs. T_J

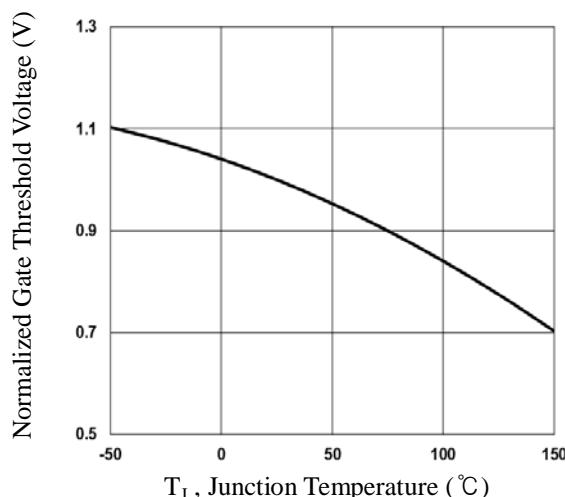


Fig.3 Normalized V_{th} vs. T_J

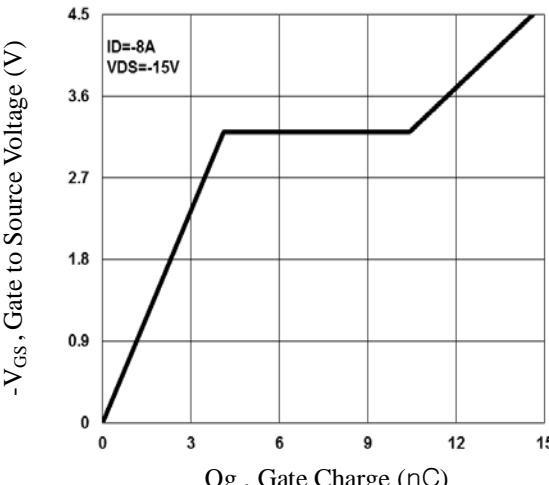


Fig.4 Gate Charge Waveform

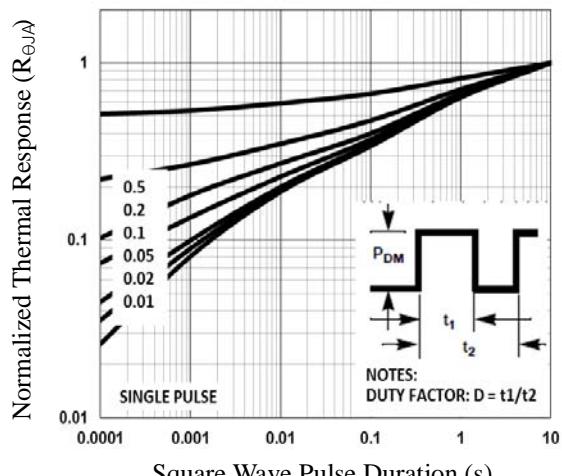


Fig.5 Normalized Transient Impedance

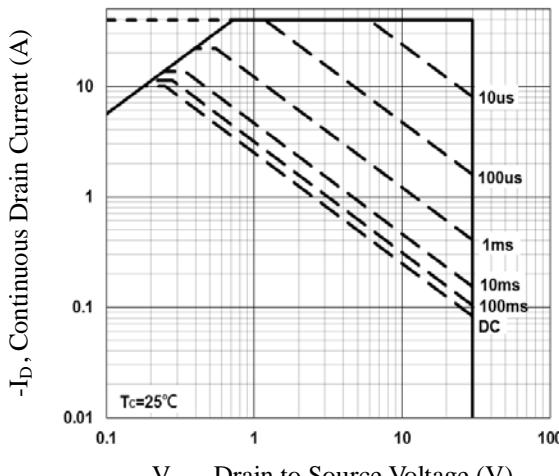


Fig.6 Maximum Safe Operation Area

30V P-ChannelMOSFETs

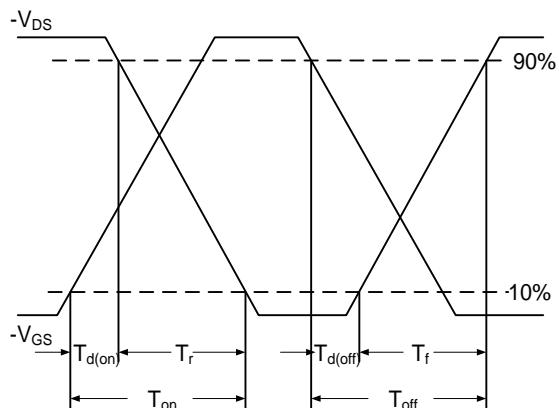


Fig.7 Switching Time Waveform

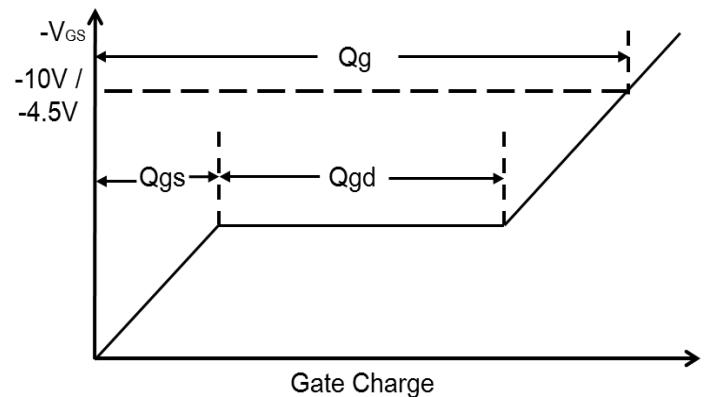
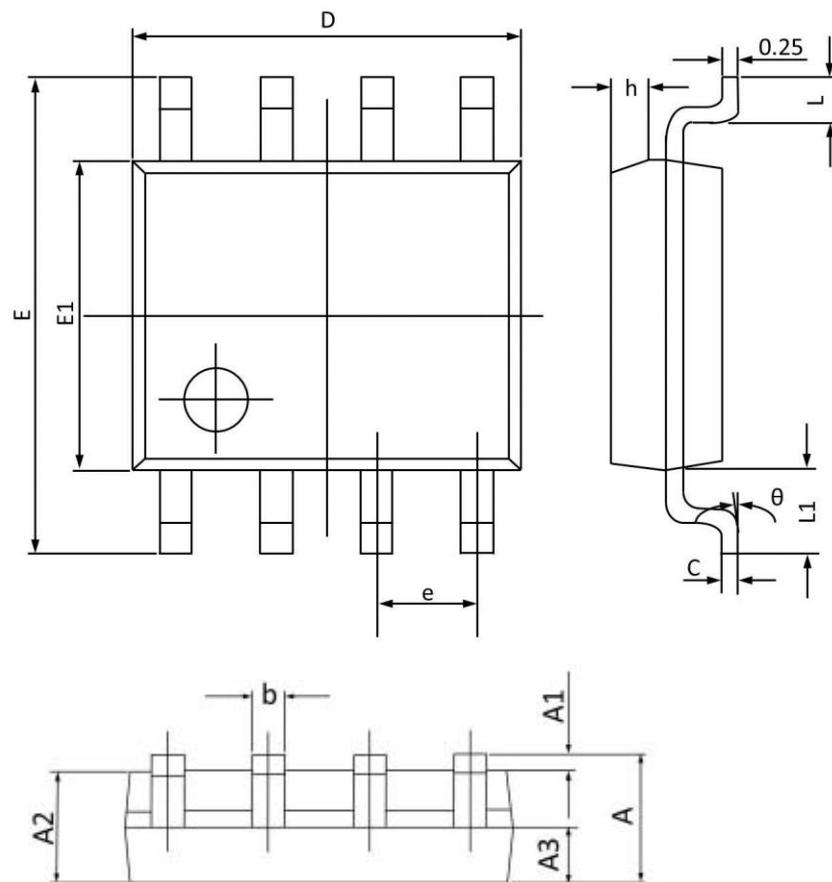


Fig.8 Gate Charge Waveform

30V P-Channel MOSFETs

SOP-8 PACKAGE INFORMATION



| Symbol | Dimensions In Millimeters | | Dimensions In Inches | |
|--------|---------------------------|-------|----------------------|-------|
| | Min | Max | Min | Max |
| A | 1.350 | 1.750 | 0.053 | 0.068 |
| A1 | 0.100 | 0.250 | 0.004 | 0.009 |
| A2 | 1.300 | 1.500 | 0.052 | 0.059 |
| A3 | 0.600 | 0.700 | 0.024 | 0.027 |
| b | 0.390 | 0.480 | 0.016 | 0.018 |
| c | 0.210 | 0.260 | 0.009 | 0.010 |
| D | 4.700 | 5.100 | 0.186 | 0.200 |
| E | 5.800 | 6.200 | 0.229 | 0.244 |
| E1 | 3.700 | 4.100 | 0.146 | 0.161 |
| e | 1.270(BSC) | | 0.050(BSC) | |
| h | 0.250 | 0.500 | 0.010 | 0.019 |
| L | 0.500 | 0.800 | 0.019 | 0.031 |
| L1 | 1.050(BSC) | | 0.041(BSC) | |
| θ | 0° | 8° | 0° | 8° |